Electronic supplementary information

Spiro[fluorene-9,9'-xanthene]-based hole transporting materials for efficient perovskite solar cells with enhanced stability

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Scheme S1. Synthesis routes of four HTMs.



Fig S1. The optimized geometries, electron distribution of HOMO, HOMO-1 and LUMO of different HTMs.



Fig S2. TGA curves of different HTMs.



Fig S3. Normalized UV-vis absorption spectra of different HTMs in DCM solution.



Fig S4. J-V characteristics of hole-only devices based on doped HTMs under dark.



Fig S5. Effect of doped mp-SFX-2PA thickness on the performance of MAPbI3 based PSCs.



Fig S6. (a) *J-V* curve of PSC based on doped spiro-OMeTAD, measured under AM 1.5G illumination, 100 mW cm⁻². (b) EQE spectrum as a function of the wavelength of monochromatic light. (c) Steady-state current density and power output measured at the maximum power point (817 mV).



Fig S7. Statistical distribution histogram of PCEs of $MAPbI_3$ PSCs with dopant (20 devices for each

case).



Fig S8. J-V curves of MAPbI₃ based devices with doped mp-SFX-2PA: (a) under different scanning

directions with 0.1 V/s rate, (b) under different scanning rate of reverse scanning. *J-V* curves of doped spiro-OMeTAD based devices: (c) under different scanning directions with 0.1 V/s rate, (d) under different scanning rate of reverse scanning.



Fig S9. (a) Steady-state current density and power output for the (FAPbI₃)_{0.85}(MAPbBr₃)_{0.15} based PSCs using doped mp-SFX-2PA and doped spiro-OMeTAD measured at the maximum power point.

J-V curves of the (FAPbI₃)_{0.85}(MAPbBr₃)_{0.15} based PSCs employing (b) doped mp-SFX-2PA and (c) doped spiro-OMeTAD under different scanning directions with 0.1 V/s rate.



Fig S10. Normalized hole mobility as a function of time for the MAPbI₃ devices based on doped mp-SFX-2PA and doped spiro-OMeTAD, stored under ambient condition (20 ± 5 °C, 15 ± 5 % relative humidity).

	mp-SFX-	mm-SFX-	mp-SFX-	mm-SFX-	spiro-
	3PA	3PA	2PA	2PA	OMeTAD
LUMO+1	-0.67	-0.66	-0.36	-0.44	-0.65
LUMO	-1.08	-1.10	-0.65	-0.72	-0.67
НОМО	-4.47	-4.47	-4.27	-4.32	-4.27
HOMO-1	-4.57	-4.48	-4.58	-4.37	-4.29

Table S1. Calculated LUMO+1, LUMO, HOMO and HOMO-1 energy levels

_	Thickness of mp-	$J_{ m SC}~(m mA~cm^{-2})$	$V_{\rm OC}~({ m mV})$	FF (%)	PCE (%)
	SFX-2PA (nm)				
-	130	20.24	1001	75.90	15.38
	100	20.75	1008	77.53	16.22
	80	19.33	997.0	78.00	15.03
	65	18.23	986.0	77.12	13.86

Table S2. Photovoltaic parameters of the MAPbI₃ based PSCs with different thickness of doped mp-SFX-2PA